

<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/531,728	EIDE, EGIL
	Examiner	Art Unit
	Chuc D. Tran	2821

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
343	700 MS	9/8/2006	TC
343	727	9/8/2006	TC
Interference Search History		9/8/2006	TC